

Search Notes

Application/Control No.

10/617,799

Examiner

Y. J. Han

Applicant(s)/Patent under
Reexamination

YOSHIKAWA, NORIAKI

Art Unit

2838

SEARCHED

Class	Subclass	Date	Examiner
323	225		
	283		
	284		
	285		
	288		
	290		
	242		
	246	3/05	JK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

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